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May 2017

# FOD814 Series, FOD817 Series 4-Pin DIP Phototransistor Optocouplers

#### **Features**

- AC Input Response (FOD814)
- Current Transfer Ratio in Selected Groups:

FOD814: 20–300% FOD817: 50–600% FOD814A: 50–150% FOD817A: 80–160%

FOD817B: 130–260% FOD817C: 200–400% FOD817D: 300–600%

- Minimum BV<sub>CEO</sub> of 70 V Guaranteed
- · Safety and Regulatory Approvals
  - UL1577, 5,000 VAC<sub>RMS</sub> for 1 Minute
  - DIN EN/IEC60747-5-5

### **Applications**

FOD814 Series

- · AC Line Monitor
- Unknown Polarity DC Sensor
- Telephone Line Interface

FOD817 Series

- Power Supply Regulators
- · Digital Logic Inputs
- Microprocessor Inputs

#### **Description**

The FOD814 consists of two gallium arsenide infrared emitting diodes, connected in inverse parallel, driving a silicon phototransistor output in a 4-pin dual in-line package. The FOD817 Series consists of a gallium arsenide infrared emitting diode driving a silicon phototransistor in a 4-pin dual in-line package.

#### **Functional Block Diagram**

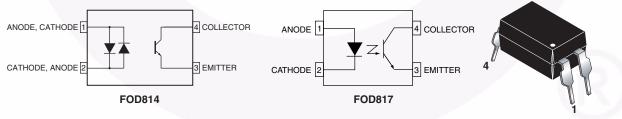


Figure 1. Schematic

Figure 2. Package Outlines

# **Safety and Insulation Ratings**

As per DIN EN/IEC 60747-5-5, this optocoupler is suitable for "safe electrical insulation" only within the safety limit data. Compliance with the safety ratings shall be ensured by means of protective circuits.

Parameter	Characteristics	
Installation Classifications per DIN VDE	< 150 V <sub>RMS</sub>	I–IV
0110/1.89 Table 1, For Rated Mains Voltage	< 300 V <sub>RMS</sub>	I–III
Climatic Classification		30/110/21
Pollution Degree (DIN VDE 0110/1.89)		2
Comparative Tracking Index		175

Symbol	Parameter	Value	Unit
V	Input-to-Output Test Voltage, Method A, $V_{IORM} \times 1.6 = V_{PR}$ , Type and Sample Test with $t_m = 10$ s, Partial Discharge < 5 pC	1360	V <sub>peak</sub>
V <sub>PR</sub>	Input-to-Output Test Voltage, Method B, $V_{IORM} \times 1.875 = V_{PR}$ , 100% Production Test with $t_m = 1$ s, Partial Discharge < 5 pC	1560	V <sub>peak</sub>
V <sub>IORM</sub>	Maximum Working Insulation Voltage	850	V <sub>peak</sub>
V <sub>IOTM</sub>	Highest Allowable Over-Voltage	8000	V <sub>peak</sub>
	External Creepage	≥ 7	mm
	External Clearance	≥ 7	mm
	External Clearance (for Option W, 0.4" Lead Spacing)	≥ 10	mm
DTI	Distance Through Insulation (Insulation Thickness)	≥ 0.4	mm
T <sub>S</sub>	Case Temperature <sup>(1)</sup>	175	°C
I <sub>S,INPUT</sub>	Input Current <sup>(1)</sup>	400	mA
P <sub>S,OUTPUT</sub>	Output Power <sup>(1)</sup>	700	mW
R <sub>IO</sub>	Insulation Resistance at T <sub>S</sub> , V <sub>IO</sub> = 500 V <sup>(1)</sup>	> 10 <sup>11</sup>	Ω

#### Note

1. Safety limit values – maximum values allowed in the event of a failure.

### **Absolute Maximum Ratings**

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.  $T_A = 25^{\circ}C$  Unless otherwise specified.

Comple at	Damamatan	Va	lue	
Symbol	Parameter	FOD814	FOD817	Unit
Total Device				
T <sub>STG</sub>	Storage Temperature	-55 to	+150	°C
T <sub>OPR</sub>	Operating Temperature	-55 to +105	-55 to +110	°C
T <sub>J</sub>	Junction Temperature	-55 to	+125	°C
T <sub>SOL</sub>	Lead Solder Temperature	260 for 10	) seconds	°C
$\theta_{\sf JC}$	Junction-to-Case Thermal Resistance	2.	10	°C/W
P <sub>TOT</sub>	Total Device Power Dissipation		00	mW
EMITTER				
I <sub>F</sub>	Continuous Forward Current	±50	50	mA
$V_{R}$	Reverse Voltage		6	V
	Power Dissipation	7	0	mW
$P_{D}$	Derate Above 100°C	1.7		mW/°C
DETECTOR				
V <sub>CEO</sub>	Collector-Emitter Voltage	70		V
V <sub>ECO</sub>	Emitter-Collector Voltage	6		V
I <sub>C</sub>	Continuous Collector Current	50		mA
Б	Collector Power Dissipation	1:	50	mW
$P_{C}$	Derate Above 90°C	2	.9	mW/°C

#### **Electrical Characteristics**

 $T_A = 25$ °C unless otherwise specified.

#### **Individual Component Characteristics**

Symbol	Parameter	Device	Test Conditions	Min.	Тур.	Max.	Unit	
EMITTER								
\/	Converd Voltage	FOD814	I <sub>F</sub> = ±20 mA		1.2	1.4	V	
$V_{F}$	Forward Voltage	FOD817	I <sub>F</sub> = 20 mA		1.2	1.4	V	
I <sub>R</sub>	Reverse Current	FOD817	V <sub>R</sub> = 4.0 V			10	μΑ	
	Terminal Canacitanes	FOD814	V = 0, f = 1 kHz		50	250	)	
C <sub>t</sub> Terminal Capacitance		FOD817	V = 0, f = 1 kHz		30	250	- pF	
DETECTO	OR				_	_		
ı	Collector Dark Current	FOD814	V <sub>CE</sub> = 20 V, I <sub>F</sub> = 0			100	nA	
I <sub>CEO</sub>	Collector Dark Current	FOD817	$V_{CE} = 20 \text{ V}, I_F = 0$			100	IIA	
D\/	Collector-Emitter Breakdown	FOD814	$I_C = 0.1 \text{ mA}, I_F = 0$	70			V	
BV <sub>CEO</sub>	Voltage	FOD817	$I_C = 0.1 \text{ mA}, I_F = 0$	70			V	
D\/	Emitter-Collector Breakdown		$I_E = 10 \mu A, I_F = 0$	6			V	
BV <sub>ECO</sub>	Voltage	FOD817	$I_E = 10 \mu A, I_F = 0$	6			1 V	

#### **DC Transfer Characteristics**

Symbol	Parameter	Device	Test Conditions	Min.	Тур.	Max.	Unit
		FOD814	I <sub>F</sub> = ±1 mA, V <sub>CE</sub> = 5 V	20		300	
		FOD814A	IF = ±1 IIIA, VCE = 5 V	50		150	
		FOD817		50		600	
CTR	Current Transfer Ratio <sup>(2)</sup>	FOD817A		80		160	%
		FOD817B	$I_F = 5 \text{ mA}, V_{CE} = 5 \text{ V}$	130		260	
		FOD817C		200		400	
		FOD817D		300		600	
V	Collector-Emitter Saturation	FOD814	$I_F = \pm 20 \text{ mA}, I_C = 1 \text{ mA}$		0.1	0.2	V
V <sub>CE(SAT)</sub>	Voltage	FOD817	$I_F = 20 \text{ mA}, I_C = 1 \text{ mA}$		0.1	0.2	V

#### **AC Transfer Characteristics**

Symbol	Parameter	Device	Test Conditions	Min.	Тур.	Max.	Unit
f <sub>C</sub>	Cut-Off Frequency	FOD814	$V_{CE} = 5 \text{ V}, I_{C} = 2 \text{ mA},$ $R_{L} = 100 \Omega, -3 \text{ dB}$	15	80		kHz
t <sub>r</sub>	Response Time (Rise)	FOD814, FOD817	$V_{CE} = 2 \text{ V, } I_{C} = 2 \text{ mA,}$ $R_{1} = 100 \ \Omega^{(3)}$		4	18	μs
t <sub>f</sub>	Response Time (Fall)	FOD814, FOD817	$R_L = 100 \Omega^{(3)}$		3	18	μs

#### Notes

- 2. Current Transfer Ratio (CTR) =  $I_C / I_F x 100\%$ .
- 3. For test circuit setup and waveforms, refer to page 7.

## **Electrical Characteristics** (Continued)

 $T_A = 25$ °C unless otherwise specified.

#### **Isolation Characteristics**

Symbol	Parameter	Device	Test Conditions	Min.	Тур.	Max.	Unit
V <sub>ISO</sub>	Input-Output Isolation Voltage <sup>(4)</sup>	FOD814, FOD817	f = 60  Hz, t = 1  minute, $I_{I-O} \le 2 \mu A$	5000			VAC <sub>RMS</sub>
R <sub>ISO</sub>	Isolation Resistance	FOD814, FOD817	V <sub>I-O</sub> = 500 V <sub>DC</sub>	5x10 <sup>10</sup>	1x10 <sup>11</sup>		Ω
C <sub>ISO</sub>	Isolation Capacitance	FOD814, FOD817	V <sub>I-O</sub> = 0, f = 1 MHz		0.6	1.0	pf

#### Note:

4. For this test, Pins 1 and 2 are common, and Pins 3 and 4 are common.

## **Typical Electrical/Optical Characteristic Curves**

 $T_A = 25$ °C unless otherwise specified.

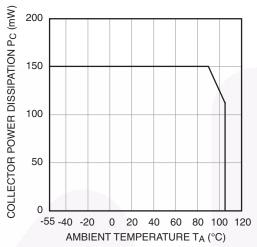


Fig. 3 Collector Power Dissipation vs. Ambient Temperature (FOD814)

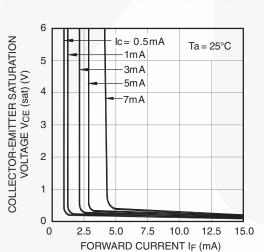


Fig. 5 Collector-Emitter Saturation Voltage vs. Forward Current

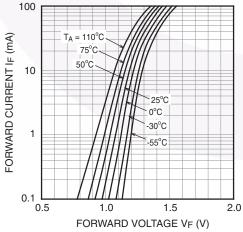


Fig. 7 Forward Current vs. Forward Voltage (FOD817)

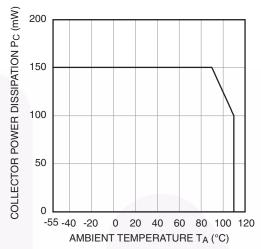


Fig. 4 Collector Power Dissipation vs. Ambient Temperature (FOD817)

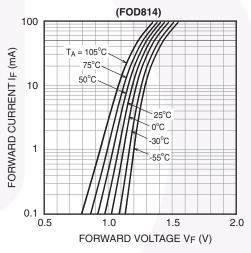


Fig. 6 Forward Current vs. Forward Voltage

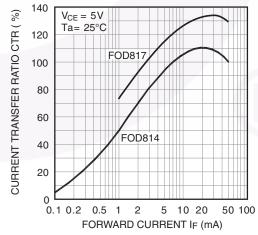


Fig. 8 Current Transfer Ratio vs. Forward Current

#### Typical Electrical/Optical Characteristic Curves (Continued)

 $T_A = 25$ °C unless otherwise specified.

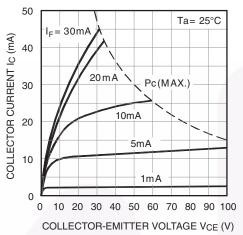


Fig. 9 Collector Current vs. Collector-Emitter Voltage (FOD814)

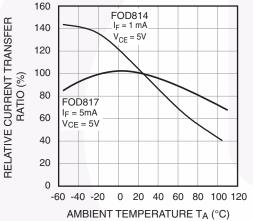
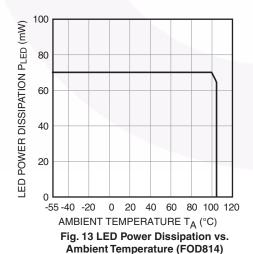


Fig. 11 Relative Current Transfer Ratio vs. Ambient Temperature



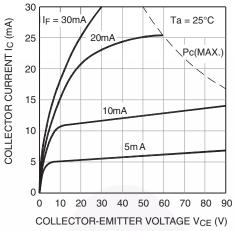


Fig. 10 Collector Current vs. Collector-Emitter Voltage (FOD817)

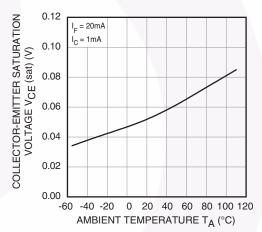


Fig. 12 Collector-Emitter Saturation Voltage vs. Ambient Temperature

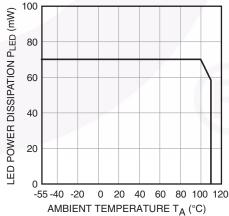


Fig. 14 LED Power Dissipation vs. Ambient Temperature (FOD817)

## Typical Electrical/Optical Characteristic Curves (Continued)

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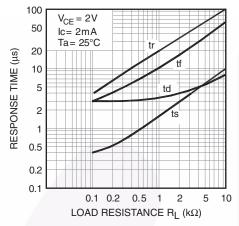


Fig. 15 Response Time vs. Load Resistance

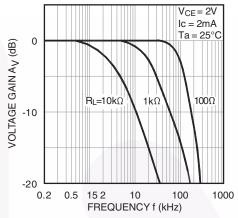


Fig. 16 Frequency Response

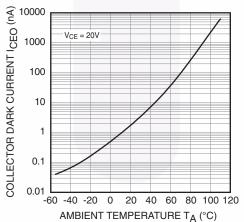
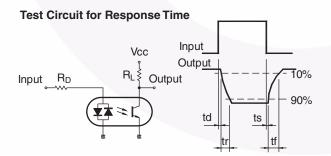
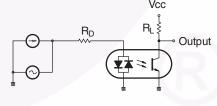


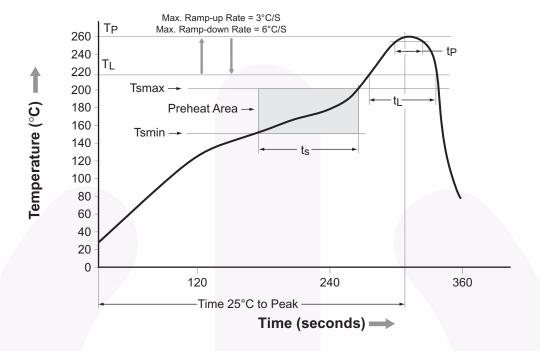
Fig. 17 Collector Dark Current vs. Ambient Temperature







#### **Reflow Profile**



Profile Feature	Pb-Free Assembly Profile
Temperature Min. (Tsmin)	150°C
Temperature Max. (Tsmax)	200°C
Time (t <sub>S</sub> ) from (Tsmin to Tsmax)	60-120 seconds
Ramp-up Rate (t <sub>L</sub> to t <sub>P</sub> )	3°C/second max.
Liquidous Temperature (T <sub>L</sub> )	217°C
Time (t <sub>L</sub> ) Maintained Above (T <sub>L</sub> )	60–150 seconds
Peak Body Package Temperature	260°C +0°C / -5°C
Time (t <sub>P</sub> ) within 5°C of 260°C	30 seconds
Ramp-down Rate (T <sub>P</sub> to T <sub>L</sub> )	6°C/second max.
Time 25°C to Peak Temperature	8 minutes max.

Figure 20. Reflow Profile

# **Ordering Information**

Part Number	Package	Packing Method
FOD817X	DIP 4-Pin	Tube (100 units per tube)
FOD817XS	SMT 4-Pin (Lead Bend)	Tube (100 units per tube)
FOD817XSD	SMT 4-Pin (Lead Bend)	Tape and Reel (1,000 units per reel)
FOD817X300	DIP 4-Pin, DIN EN/IEC60747-5-5 option	Tube (100 units per tube)
FOD817X3S	SMT 4-Pin (Lead Bend), DIN EN/IEC60747-5-5 option	Tube (100 units per tube)
FOD817X3SD	SMT 4-Pin (Lead Bend), DIN EN/IEC60747-5-5 option	Tape and Reel (1,000 units per reel)
FOD817X300W	DIP 4-Pin, 0.4" Lead Spacing, DIN EN/IEC60747-5-5 option	Tube (100 units per tube)

#### Note:

The product orderable part number system listed in this table also applies to the FOD814 products.

# **Marking Information**

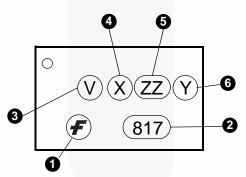


Figure 21. Top Mark

Definiti	Definitions					
1	Fairchild Logo					
2	Device Number					
3	DIN EN/IEC60747-5-5 Option (only appears on parts ordered with this option)					
4	One-Digit Year Code, e.g., '5'					
5	Two-Digit Work Week, Ranging from '01' to '53'					
6	Assembly Package Code Y = Manufactured in Thailand YA = Manufactured in China					

<sup>&</sup>quot;X" denotes the Current Transfer Ratio (CTR) options

# **Carrier Tape Specifications**

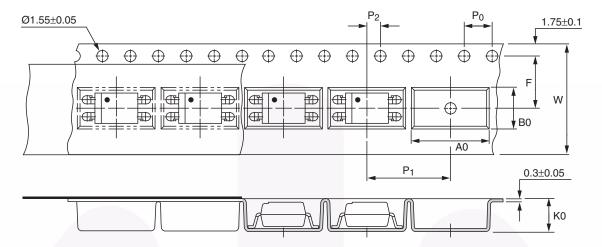
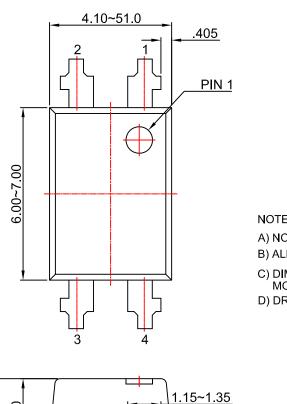


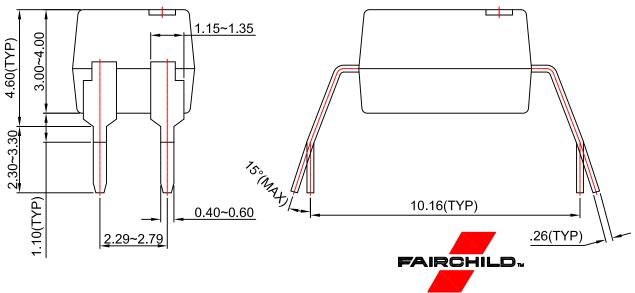
Figure 22. Carrier Tape Specification

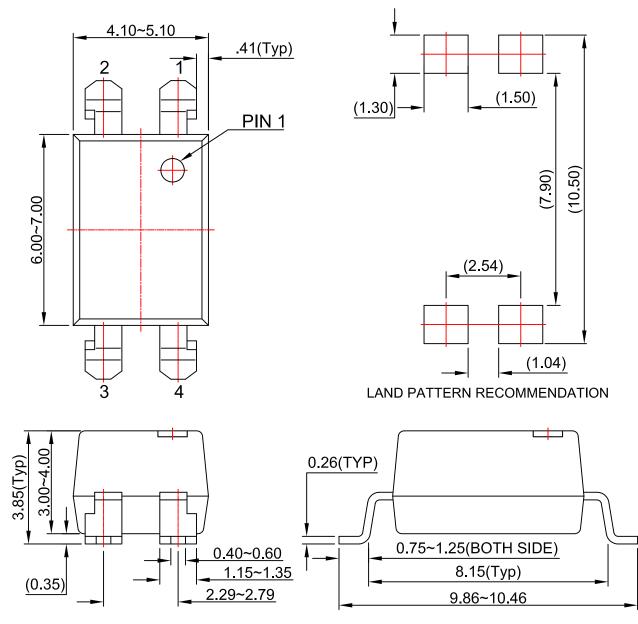
Symbol	Description	Dimensions in mm (inches)
W	Tape wide	16 ± 0.3 (0.63)
P <sub>0</sub>	Pitch of sprocket holes	4 ± 0.1 (0.15)
F P <sub>2</sub>	Distance of compartment	7.5 ± 0.1 (0.295) 2 ± 0.1 (0.079)
P <sub>1</sub>	Distance of compartment to compartment	12 ± 0.1 (0.472)
A0	Compartment	10.45 ± 0.1 (0.411)
B0		5.30 ± 0.1 (0.209)
K0		4.25 ± 0.1 (0.167)



#### NOTES:

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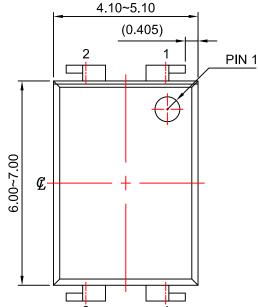




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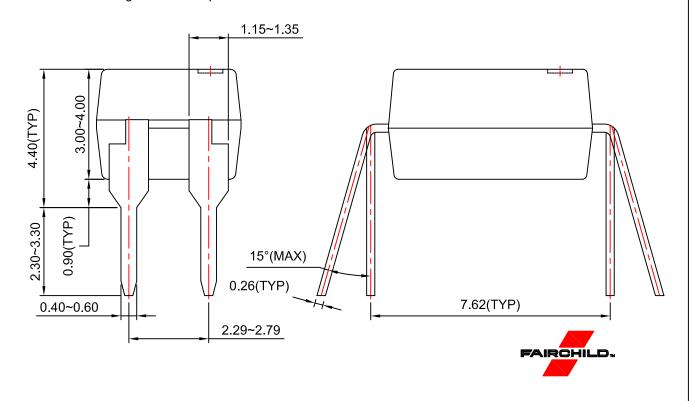
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